


<b>Search Notes</b>  	<b>Application/Control No.</b>  10694986	<b>Applicant(s)/Patent Under Reexamination</b>  NAGAI ET AL.
	<b>Examiner</b>  DABORAH CHACKO DAVIS	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
(430/318,329,328,326,313,165)-updated text search only-see updated search history print out	06/01/2010	dcd
East (USPAT, US-PGPUB, FPRS, EPO, JPO, IBM-TDB, DERWENT)-see updated search history print out	06/02/2010	dcd
Updated search history print out	06/10/2010	dcd
eDAN inventor search performed	06/01/2010	dcd

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Interference search performed-see interference search history print out	06/10/2010	dcd

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